

AS1339

650mA RF Step-Down DC-DC for PA, with two LDOs

1 General Description

The AS1339 is a high-frequency step-down converter optimized for dynamically powering the power amplifier (PA) in WCDMA or NCDMA handsets. The device uses a 110mΩ typical bypass FET to power the PA directly from the battery during high-power transmission. The IC integrates two 10mA low-noise, low-dropout regulators (LDOs) for PA biasing.

With a switching frequency of 2MHz, the device allows optimization for smallest solution size or highest efficiency. The AS1339 supports fast switching using small ceramic 10μF input and 4.7μF output capacitors to maintain low ripple voltage.

The AS1339 uses an analog input driven by an external DAC to control the output voltage linearly for continuous PA power adjustment. The gain from REFIN to OUT is 2.5V/V. At high-duty cycle, the device automatically switches to a bypass mode, connecting the input to the output through a low-impedance MOSFET. The LDOs are designed for low-noise operation, wherein each LDO in the device is individually enabled through its own logic control interface. The device is available in a 16-pin WLP (2x2mm) package.

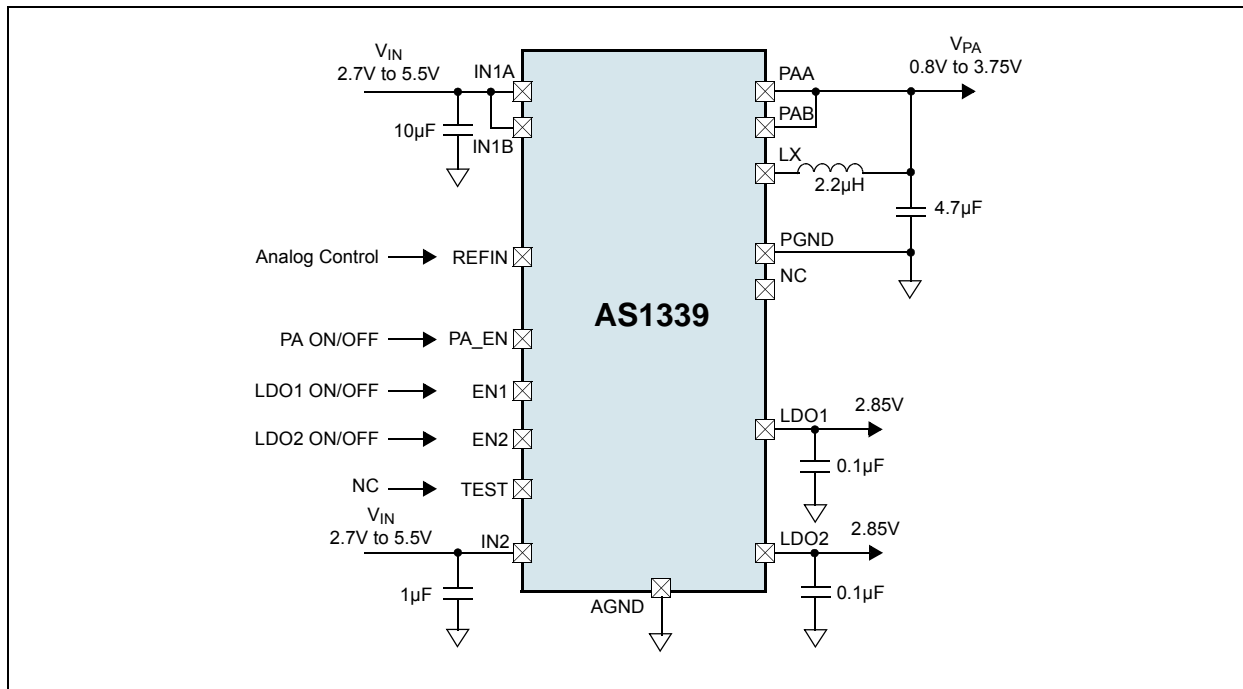
2 Key Features

- Fixed Switching Frequency: 2MHz
- PA Step-Down Converter
- Low Dropout Voltage
- Low Output-Voltage Ripple
- Dynamic Output Voltage Control (0.8V to 3.75V)
- 30μs Settling Time for 0.8V to 3.4V Output Voltage Change
- 650mA Output Drive Capability
- Two 10mA Low-Noise LDOs
- Low Shutdown Current
- Supply Voltage Range: 2.7V to 5.5V
- Thermal Shutdown
- 16-pin WLP (2x2mm) package

3 Applications

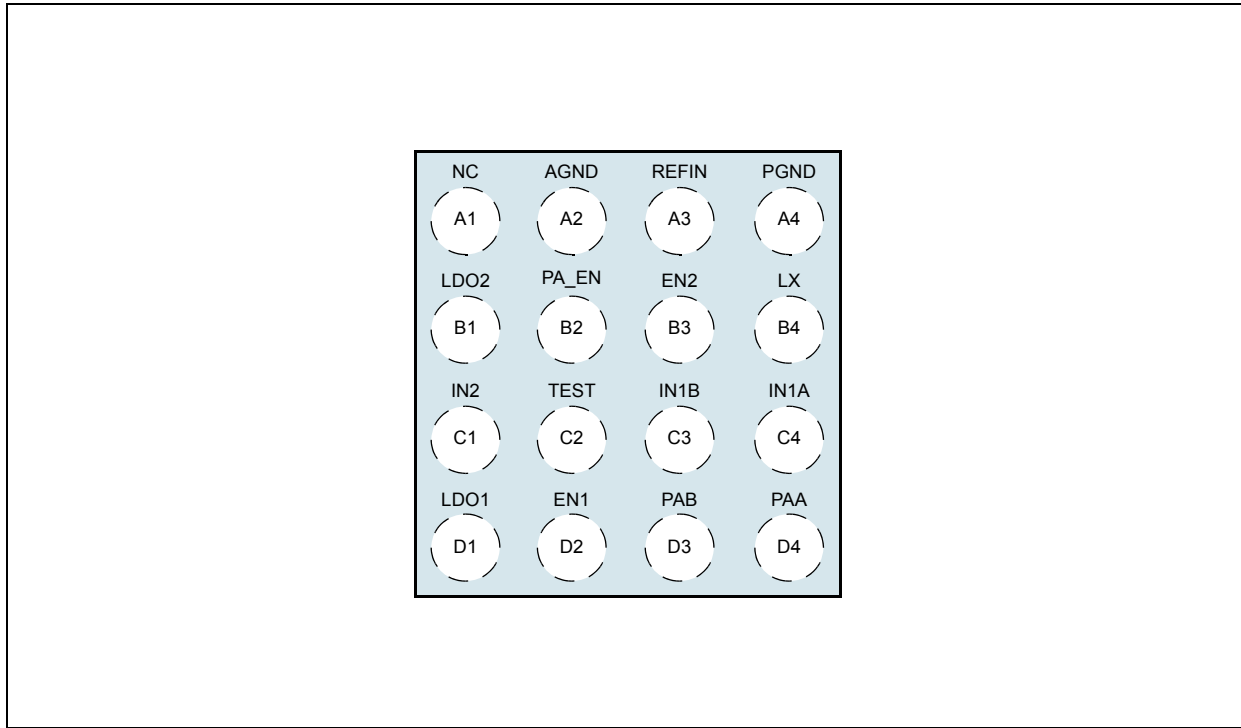
The AS1339 is ideal for WCDMA/NCDMA cellular handsets, Wireless PDAs, and Smartphones.

Figure 1. AS1339 - Typical Operating Circuit



4 Pinout

Figure 2. Pin Assignments (Top View)



Pin Description

Table 1. Pin Description

Pin Name	Pin Number	Description
NC	A1	Not Connected. Free, high impedance for normal operation. Used for internal test purpose.
AGND	A2	Low-Noise Analog Ground
REFIN	A3	DAC-Controlled Input. Reference voltage for buck converter. The output of the PA step-down converter is regulated to $2.5 \times V_{REFIN}$. Bypass mode is enabled when $V_{IN} \leq 2.69V \times V_{REFIN}$.
PGND	A4	Power Ground for PA Step-Down Converter
LDO2	B1	10mA LDO Regulator 2 Output. Connect LDO2 with a 0.1µF ceramic capacitor as close as possible to LDO2 and AGND. LDO2 is internally pulled down through a 100Ω resistor when this regulator is disabled.
PA_EN	B2	PA Step-Down Converter Enable Input. For normal operation, connect to logic-high. For shutdown mode, connect to logic-low. The pin is internally pulled down through a 110kΩ resistor.
EN2	B3	Enable Input for LDO2. For normal operation, connect to logic-high. For shutdown mode, connect to logic-low. The pin is internally pulled down through a 110kΩ resistor.
LX	B4	Inductor Connection. Connect an inductor from LX to the output of the PA step-down converter.

Table 1. Pin Description

Pin Name	Pin Number	Description
IN2	C1	Supply Voltage Input for LDO1 and LDO2. Connect IN2 to a battery or supply voltage from 2.7V to 5.5V. Decouple IN2 with a 1 μ F ceramic capacitor as close as possible to IN2 and AGND. Connect IN2 to the same source as IN1A and IN1B.
TEST	C2	NC. Used for internal test purpose. The pin is internally pulled down with a 110k Ω resistor.
IN1B, IN1A	C3, C4	Supply Voltage Input for PA Step-Down Converter. Connect IN1A/B to a battery or supply voltage from 2.7V to 5.5V. Decouple IN1A/B with a 10 μ F ceramic capacitor as close as possible to IN1A/B, and PGND. IN1A and IN1B are internally connected together. Connect IN1A/B to the same source as IN2.
LDO1	D1	10mA LDO Regulator 1 Output. Decouple LDO1 with a 0.1 μ F ceramic capacitor as close as possible to LDO1 and AGND. LDO1 is internally pulled down through a 100 Ω resistor when this regulator is disabled.
EN1	D2	Enable Input for LDO1. For normal operation, connect to logic-high. For shutdown mode, connect to logic-low. The pin is internally pulled down through a 110k Ω resistor.
PAB, PAA	D3, D4	PA Connection for Bypass Mode. Internally connected to IN1A/B using the internal bypass MOSFET during bypass mode. Connect PAA/B with a 4.7 μ F ceramic capacitor as close as possible to PAA/B and PGND.

5 Absolute Maximum Ratings

Stresses beyond those listed in [Table 2](#) may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in [Electrical Characteristics on page 5](#) is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Table 2. Absolute Maximum Ratings

Parameter	Min	Max	Units	Comments
IN1A, IN1B, IN2 to AGND	-0.3	+7	V	
PAA, PAB, PA_EN, TEST, REFIN, NC to AGND	-0.3	$V_{IN1A}/V_{IN1B} + 0.3$	V	
LDO1, LDO2, EN1, EN2 to AGND	-0.3	$V_{IN2} + 0.3$	V	
REFIN Common-Mode Range	0	V_{IN}	V	
IN2 to IN1B/IN1A	-0.3	+0.3	V	
PGND to AGND	-0.3	+0.3	V	
LX Current		0.8	ARMS	
Bypass Current		1.6	ARMS	
Human Body Model		1	kV	HBM MIL-Std. 883E 3015.7 methods
Storage Temperature Range	-65	+150	°C	
Package Body Temperature		+260	°C	The reflow peak soldering temperature (body temperature) specified is in accordance with IPC/JEDEC J-STD-020D "Moisture/Reflow Sensitivity Classification for Non-Hermetic Solid State Surface Mount Devices".
Continuous Power Dissipation P_{D-MAX}		0.75	W	$T_A = +65^{\circ}\text{C}$; derate 12.5mW/°C above +65°C
Junction Temperature (T_J) Range	-40	+125	°C	
Ambient Temperature (T_A) Range	-40	+85	°C	In applications where high power dissipation and/or poor package thermal resistance is present, the maximum ambient temperature may have to be derated. Maximum ambient temperature (T_{A-MAX}) is dependent on the maximum operating junction temperature ($T_{J-MAX-OP} = 125^{\circ}\text{C}$), the maximum power dissipation of the device in the application (P_{D-MAX}), and the junction-to ambient thermal resistance of the part/package in the application (θ_{JA}), as given by the following equation: $T_{A-MAX} = T_{J-MAX-OP} - (\theta_{JA} \times P_{D-MAX})$.

6 Electrical Characteristics

$V_{IN1A} = V_{IN1B} = V_{IN2} = V_{PA_EN} = V_{EN1} = V_{EN2} = 3.6V$, $T_A = -40^{\circ}C$ to $+85^{\circ}C$. Typical values are at $T_A = +25^{\circ}C$, (unless otherwise specified), for external components refer to [Table 5 on page 7](#).

Table 3. Electrical Characteristics

Symbol	Parameter	Condition	Min	Typ	Max	Unit
Input Supply						
V_{IN}	Input Voltage Range		2.7		5.5	V
ISHDN	Shutdown Supply Current	$V_{PA_EN} = V_{EN1} = V_{EN2} = 0V^1$		0.1	1	μA
I_Q	DC-DC No-Load Supply Current	$V_{EN1} = V_{EN2} = 0V$, $I_{LOAD(DCDC)} = 0mA$, switching, $V_{IN} = 4.5V$, $V_{OUT} = 3.4V$		4.5	6	mA
DCDC Output Voltage						
I_{LOAD}	Load Current				650	mA
V_{OUT}	Output Voltage	PWM Mode	0.8		3.85	V
		$V_{REFIN} = 0.32V$, $V_{IN} = 3.9V$	0.75	0.8	0.85	V
		$V_{REFIN} = 0.84V$, $V_{IN} = 3.9V$	2.05	2.1	2.15	V
		$V_{REFIN} = 1.36V$, $V_{IN} = 3.9V$	3.319	3.4	3.481	V
Thermal Protection						
	Thermal Shutdown	T_A rising, $10^{\circ}C$ typical hysteresis		+140		$^{\circ}C$
Logic Control						
	PA_EN, EN1, EN2, Logic-Input High Voltage	$2.7V \leq V_{IN} \leq 5.5V$	1.4			V
	PA_EN, EN1, EN2, Logic-Input Low Voltage	$2.7V \leq V_{IN} \leq 5.5V$			0.5	V
	Logic-Input Current (PA_EN, EN1, EN2)	$V_{IL} = 0V$	-1		+1	μA
		$V_{IH} = V_{IN} = 5.5V$		50	75	μA
REFIN						
	REFIN Operating Common-Mode Range		0.32		1.5	V
	REFIN gain V_{OUT}/V_{REFIN}^2	$V_{REFIN} = 0.32V$	2.35	2.50	2.65	V/V
		$V_{REFIN} = 0.84V, 1.36V$	2.44	2.50	2.56	V/V
	REFIN Current	$V_{REFIN} = V_{IN} = 5.5V$	-1		+1	μA
LX						
$R_{DS(ONP)}$	Pin-Pin Resistance for PFET	$I_{SW} = 200mA$; $T_A = +25^{\circ}C$		110	200	m Ω
		$I_{SW} = 200mA$			230	
$R_{DS(ONN)}$	Pin-Pin Resistance for NFET	$I_{SW} = -200mA$; $T_A = +25^{\circ}C$		230	415	m Ω
		$I_{SW} = -200mA$			485	
	PFET Leakage Current	$V_{IN} = 5.5V$, $V_{LX} = 0V$		0.1	3	μA
	NFET Leakage Current	$V_{IN} = V_{LX} = 5.5V$		0.1	3	μA
	PFET Peak Current Limit	$V_{LX} = 0V$		1100		mA

Table 3. Electrical Characteristics (Continued)

Symbol	Parameter	Condition	Min	Typ	Max	Unit
f_{OSC}	Internal Oscillator Frequency		1.8	2	2.2	MHz
BYPASS						
	Bypass Activation Factor	VREFIN rising, 50mV hysteresis	2.56	2.69	2.78	V/V
	On-Resistance Bypass PFET	$I_{SW} = 200\text{mA}$; $T_A = +25^\circ\text{C}$		110	200	m Ω
		$I_{SW} = 200\text{mA}$			230	
	PFET Bypass Off-Leakage Current	$V_{IN} = 5.5\text{V}$, $V_{PAA} = V_{PAB} = 0\text{V}$		0.1	3	μA
LDO1/2						
	Output Voltage	$I_{OUT} = 0\text{mA}, 10\text{mA}$;	2.75	2.85	2.95	V
	Quiescent Current	one LDO enabled	$I_{OUT} = 0\text{mA}$	25	50	μA
		both LDOs enabled		40	80	
	Output Current		10			mA
	Current Limit	$V_{OUT} = 0\text{V}$	20	35	50	
	Dropout Voltage ³	$I_{OUT} = 10\text{mA}$		20	50	mV
ROFF	Shutdown Output Impedance	$V_{EN1/2} = 0\text{V}$		100		Ω

1. Current into supply pins without leakage of DCDC switches.
2. Limited by the 50mV output voltage accuracy for $V_{REFIN} < 0.84\text{V}$
3. The dropout voltage is the input to output difference at which the output is 100mV below its nominal value.

System Characteristics

$V_{IN1A} = V_{IN1B} = V_{IN2} = V_{PA_EN} = V_{EN1} = V_{EN2} = 3.9\text{V}$, $T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$. Typical values are at $T_A = +25^\circ\text{C}$, (unless otherwise specified), for external components refer to Table 5 on page 7. The following parameters are verified by characterisation and are not production tested.

Table 4. System Characteristics

Symbol	Parameter	Condition	Min	Typ	Max	Unit
REFIN						
	REFIN gain variation; relative linearity ¹	$0.32\text{V} \leq V_{REFIN} \leq 1.4\text{V}$			3	%
	REFIN gain variation; absolute linearity ²	$0.84\text{V} \leq V_{REFIN} \leq 1.4\text{V}$	-2.4		2.4	%
		$0.32\text{V} \leq V_{REFIN} \leq 0.84\text{V}$	-50	± 10	50	mV
LX						
	Ripple voltage, PWM mode ³	$V_{OUT} = 0.8$ to 3.4V , $R_{LOAD} = 8\Omega$, no bypass mode, no pulse-skip condition		10	25	mVp-p
Line_tr	Line transient response	$V_{IN} = 3.4$ to 3.9V , $V_{OUT} = 3.0\text{V}$, $I_{OUT} = 300\text{mA}$, V_{IN} increase 300mV in $10\mu\text{s}$		30	50	
Load_tr	Load transient response	$V_{IN} = 3.4$ to 4.2V , $V_{OUT} = 3.0\text{V}$, $T_{RISE} = T_{FALL} = 10\mu\text{s}$, $I_{OUT} = 100$ to 300mA		50	70	

Table 4. System Characteristics (Continued)

Symbol	Parameter	Condition	Min	Typ	Max	Unit
	Start-Up Time	From PA_EN switch from 0V to 1.7V, V _{OUT} = 3.4V, I _{LOAD} = 0mA, within 50mV regulation error		100	150	μs
	Regulation Time; Rise Time	V _{OUT} from 0.8V to 3.4V, R _{LOAD} = 8Ω, within 50mV regulation error		30	50	
	Regulation Time; Fall Time	V _{OUT} from 3.4V to 0.8V, R _{LOAD} = 8Ω, within 50mV regulation error		30	50	
LDO						
	Start-Up Time	I _{OUT} =10mA, within 100mV of V _{OUT}		30	50	μs
	Shut-Down Time	I _{OUT} =0mA, within 100mV of GND		50	100	
	Line Regulation ⁴	V _{IN} = 4V to 3.5V; I _{OUT} = 10mA;			10	mV
	Load Regulation	I _{OUT} stepped from 50μA to 10mA			25	
	Ripple Rejection ⁵	I _{OUT} = 4mA, V _{IN} = 3.2V, f = 100kHz	45			dB
		I _{OUT} = 4mA, V _{IN} = 3.2V, f = 2MHz	45			
	Output Noise ⁶	10Hz to 100kHz, I _{OUT} = 10mA		50	100	μVRMS

- The relative linearity is defined as the difference of the minimum to the maximum gain over the entire REF_{IN} range.
- The absolute linearity is defined as the actual gain error (AE) of every applied V_{REF_{IN}} voltage between 0.32V and 1.4V.

$$AE = \left(\frac{V_{OUT}}{2,5 \times V_{REFIN}} - 1 \right) \times 100$$

- The ripple voltage should be measured at C_{OUT} electrode on good layout PC board and under condition using suggested inductors and capacitors.
- For dynamic change in V_{OUT} (Line transient response) when V_{IN} drops 500mV from 4V (see Figure 48 on page 15); Slew rate= 40mV/μs.
- V_{RIPPLE} = 200mV_{pp}; T_A = +25°C; C_{IN1}, C_{IN2} removed; PA_EN = 0V;
- V_{IN} = 3.2V; T_A = +25°C; PA_EN = 3.2V;

Table 5. External Components used for Characterisation

Name	Part Number	Value	Rating	Type	Size	Manufacturer
C _{IN1}	GRM21BR60J106KE01	10μF	6.3V	X5R	0805	Murata www.murata.com
C _{IN2}	GRM155R61A105KE15	1μF	10V	X5R	0402	
C _{OUT}	C0603C475K8PAC7867	4.7μF	10V	X5R	0603	KEMET www.kemet.com
CLDO1, CLDO2	C0402C104K4RAC	100nF	16V	X7R	0402	
L	MLP2520S3R3S	3.3μH	1A	110mΩ	2.2x2.0x1.4mm	TDK www.coilcraft.com

7 Typical Operation Characteristics

Figure 3. DC-DC Efficiency vs. V_{OUT} ; $R_{LOAD} = 5\Omega$

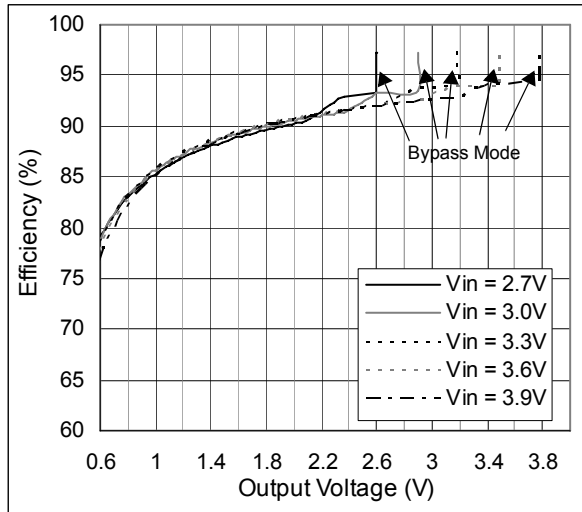


Figure 4. DC-DC Efficiency vs. V_{OUT} ; $R_{LOAD} = 7.5\Omega$

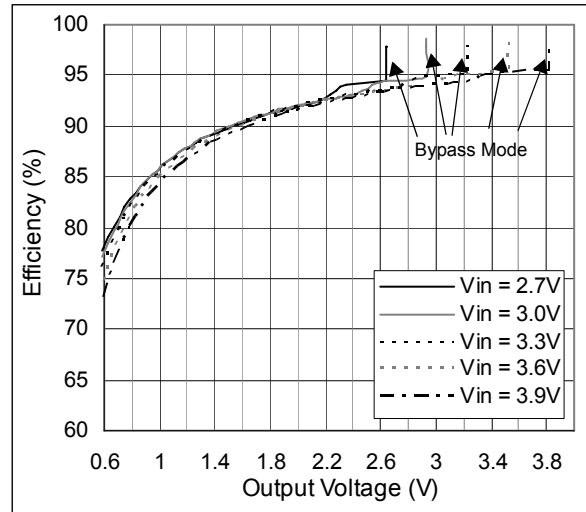


Figure 5. DC-DC Efficiency vs. V_{OUT} ; $R_{LOAD} = 10\Omega$

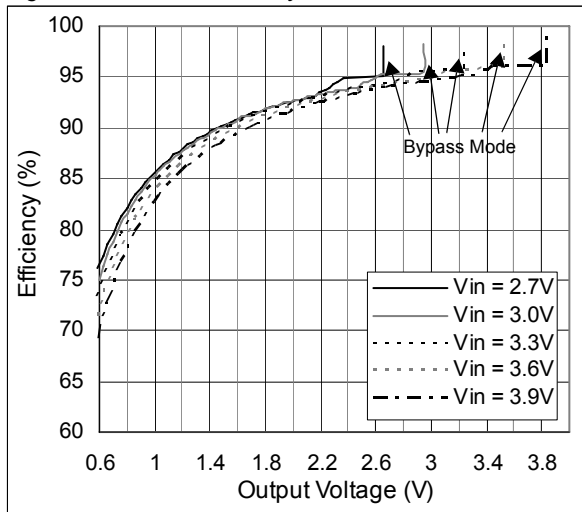


Figure 6. DC-DC $REFIN$ vs. V_{OUT} ; $R_{LOAD} = 5\Omega$

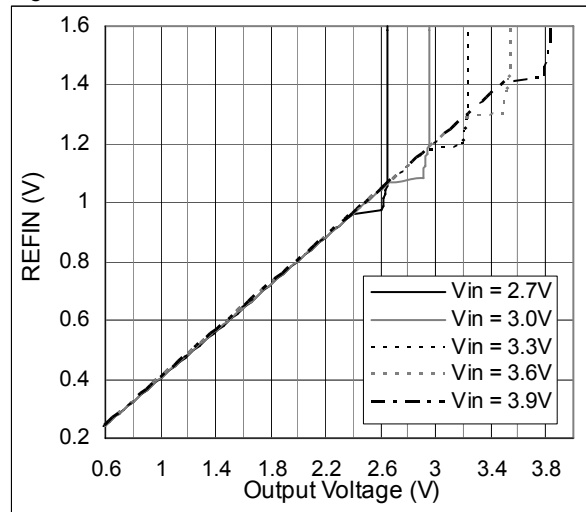


Figure 7. DC-DC $REFIN$ vs. V_{OUT} ; $R_{LOAD} = 7.5\Omega$

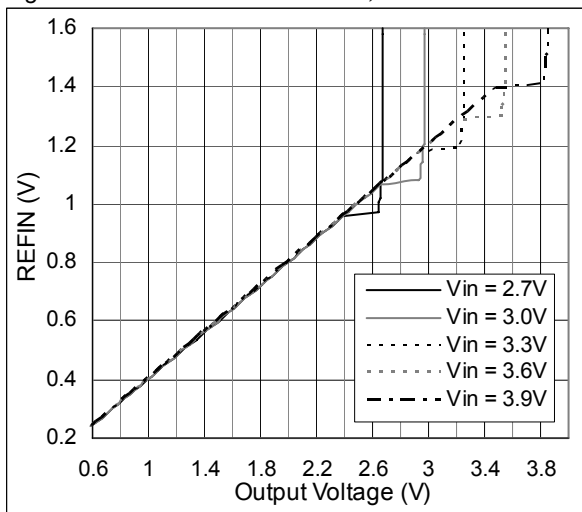


Figure 8. DC-DC $REFIN$ vs. V_{OUT} ; $R_{LOAD} = 10\Omega$

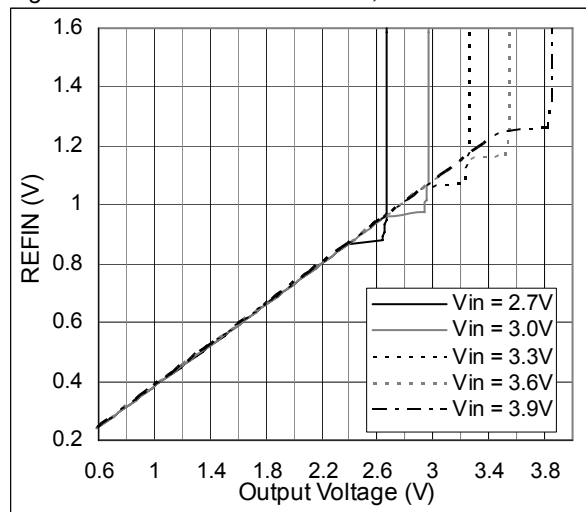


Figure 9. DC-DC Efficiency vs. I_{OUT} ; $V_{OUT} = 0.8V$

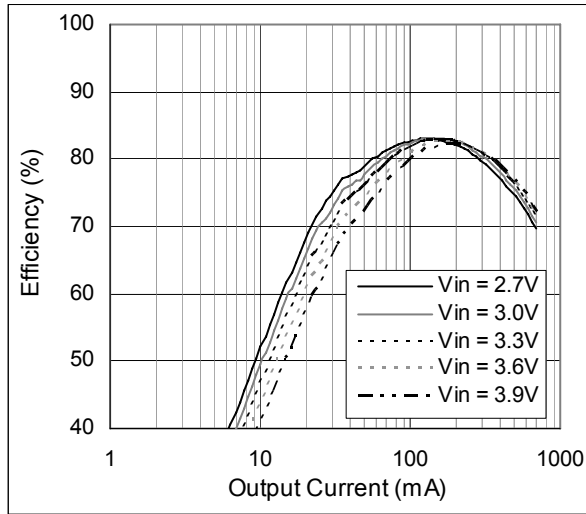


Figure 10. DC-DC Efficiency vs. I_{OUT} ; $V_{OUT} = 1.2V$

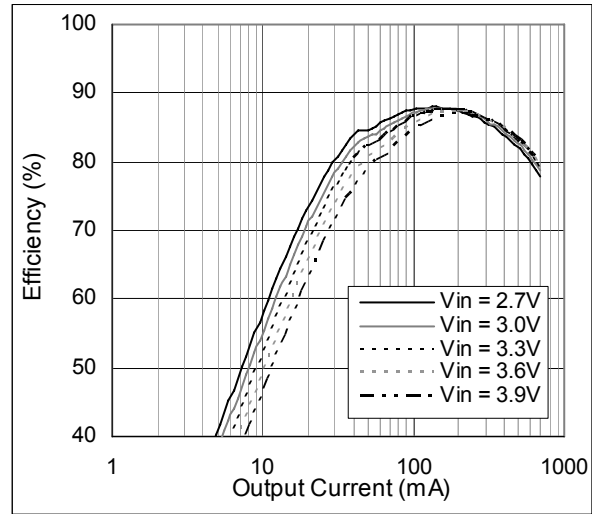


Figure 11. DC-DC Efficiency vs. I_{OUT} ; $V_{OUT} = 1.8V$

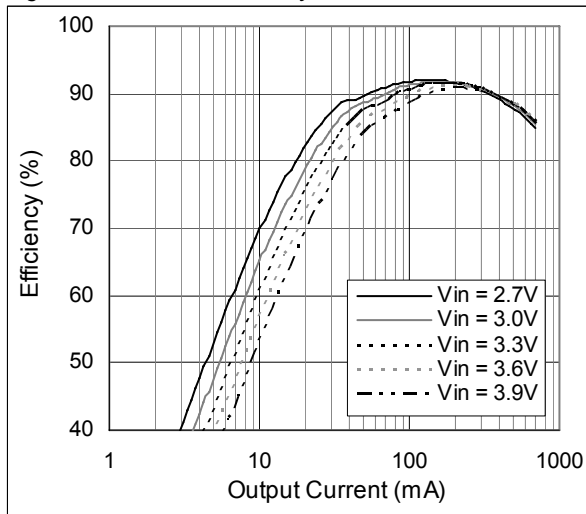


Figure 12. DC-DC Efficiency vs. I_{OUT} ; $V_{OUT} = 2.2V$

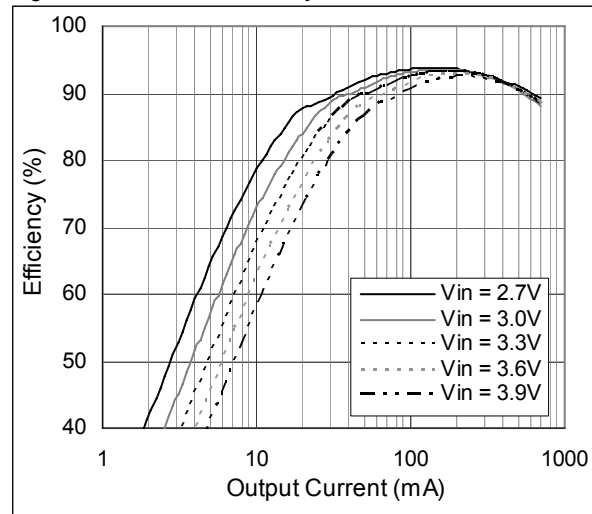


Figure 13. DC-DC Load Regulation, V_{OUT} vs. I_{OUT} ; $V_{OUT} = 0.8V$

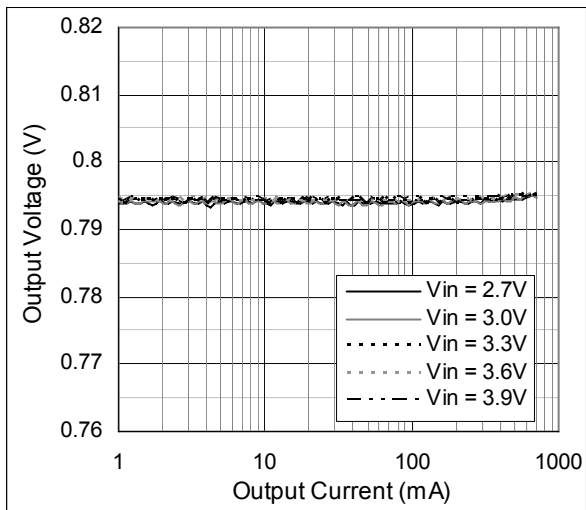


Figure 14. DC-DC Load Regulation, V_{OUT} vs. I_{OUT} ; $V_{OUT} = 1.2V$

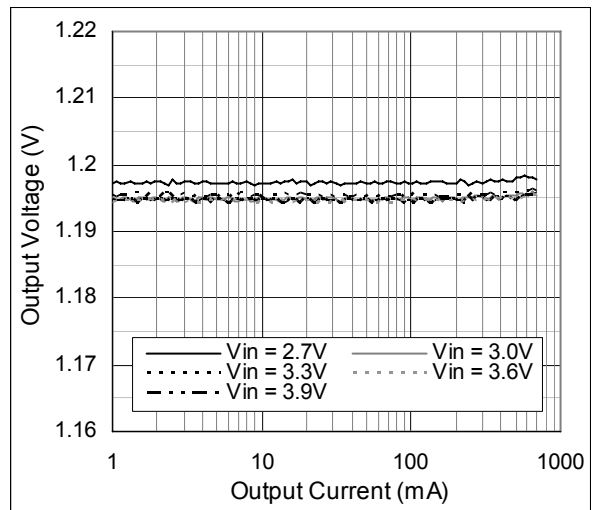


Figure 15. DC-DC Load Regulation, V_{OUT} vs. I_{OUT} ; $V_{OUT} = 1.8V$

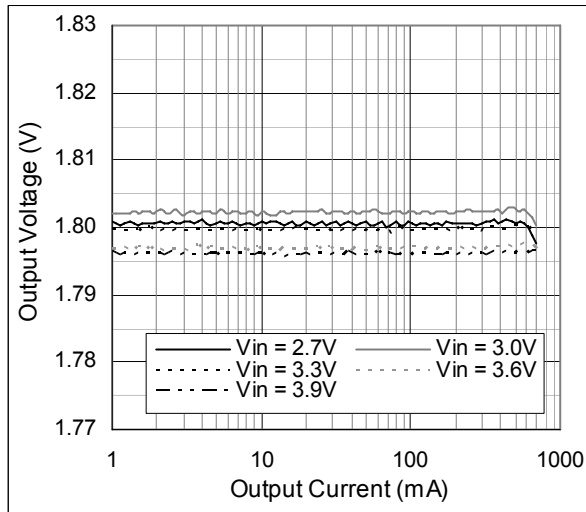


Figure 16. DC-DC Load Regulation, V_{OUT} vs. I_{OUT} ; $V_{OUT} = 2.2V$

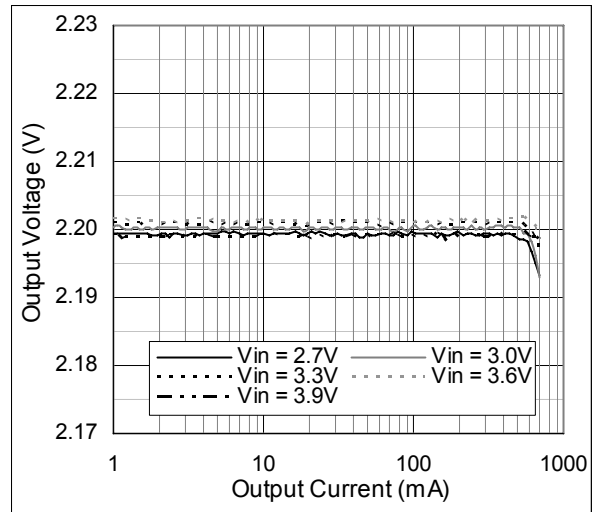


Figure 17. DC-DC Efficiency vs V_{IN} ; $V_{OUT} = 3.8V$

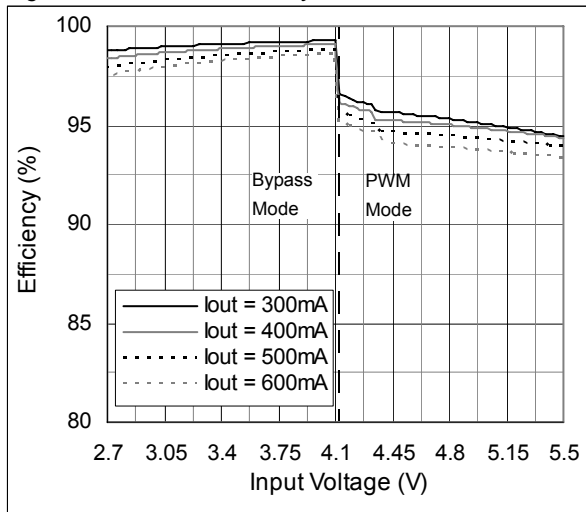


Figure 18. DC-DC Efficiency vs V_{IN} ; $V_{OUT} = 3.4V$

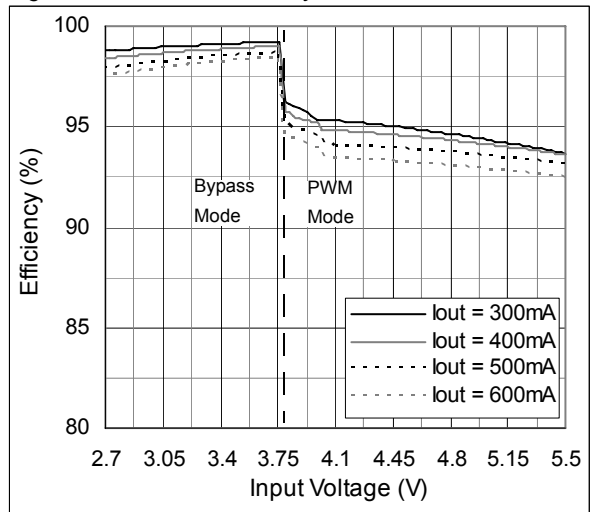


Figure 19. DC-DC Efficiency vs V_{IN} ; $V_{OUT} = 2.0V$

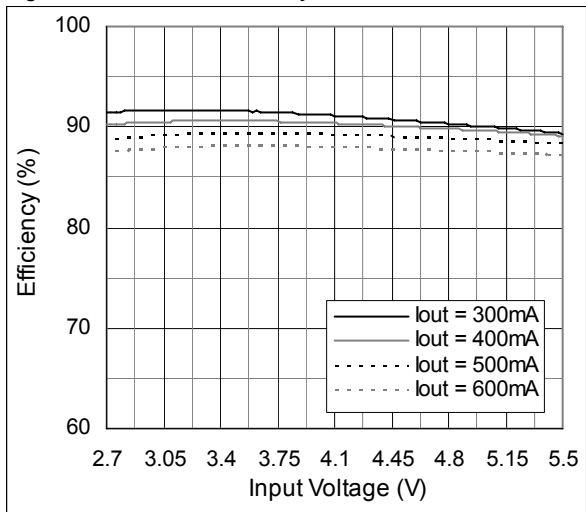


Figure 20. DC-DC Efficiency vs V_{IN} ; $V_{OUT} = 1.5V$

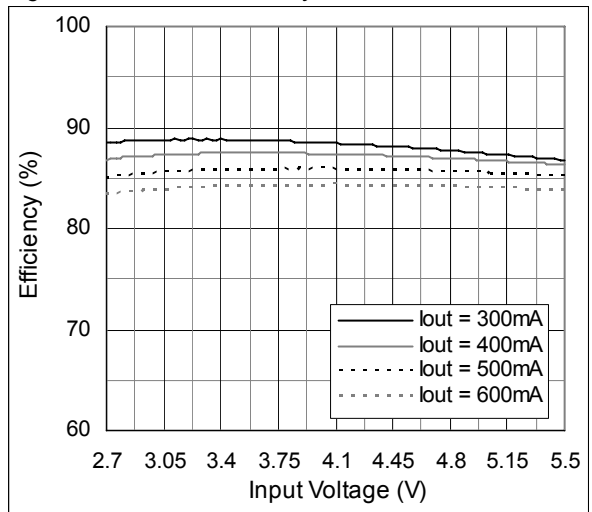


Figure 21. DC-DC Efficiency vs Input Voltage;
 $V_{OUT} = 1.0V$

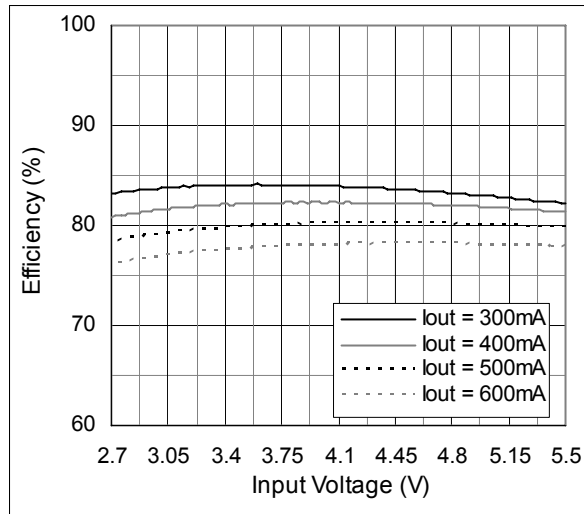


Figure 22. DC-DC Line Regulation, V_{OUT} vs. V_{IN} ;
 $V_{OUT} = 3.8V$

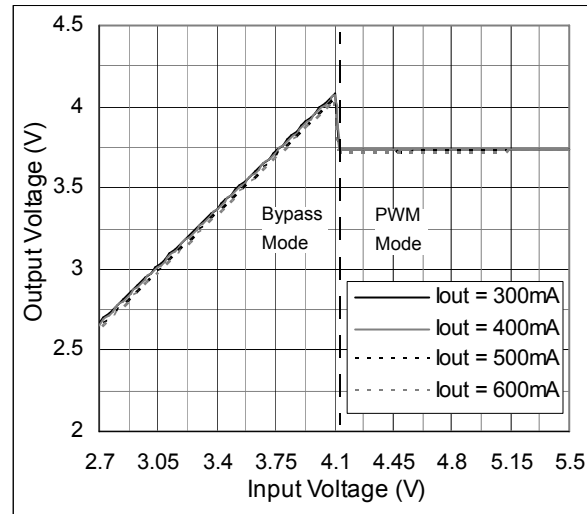


Figure 23. DC-DC Line Regulation, V_{OUT} vs. V_{IN} ;
 $V_{OUT} = 3.4V$

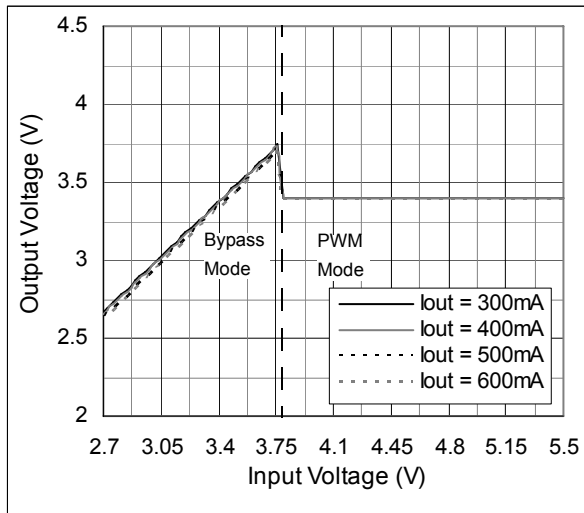


Figure 24. DC-DC Line Regulation, V_{OUT} vs. V_{IN} ;
 $V_{OUT} = 2.0V$

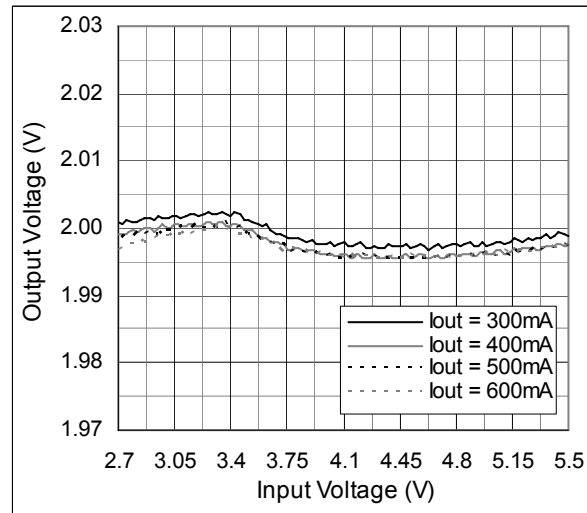


Figure 25. DC-DC Line Regulation, V_{OUT} vs. V_{IN} ;
 $V_{OUT} = 1.5V$

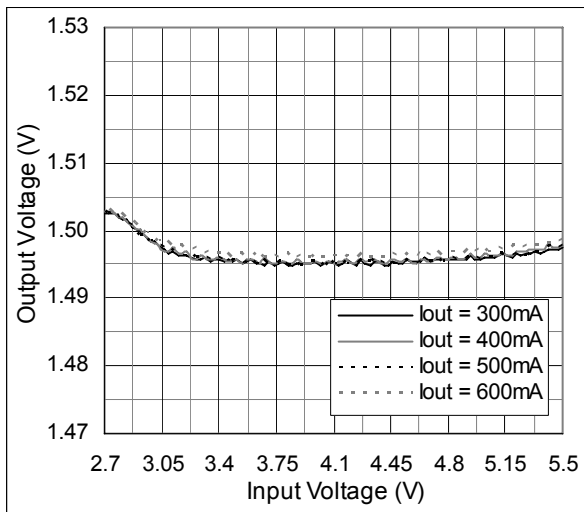


Figure 26. DC-DC Line Regulation, V_{OUT} vs. V_{IN} ;
 $V_{OUT} = 1.0V$

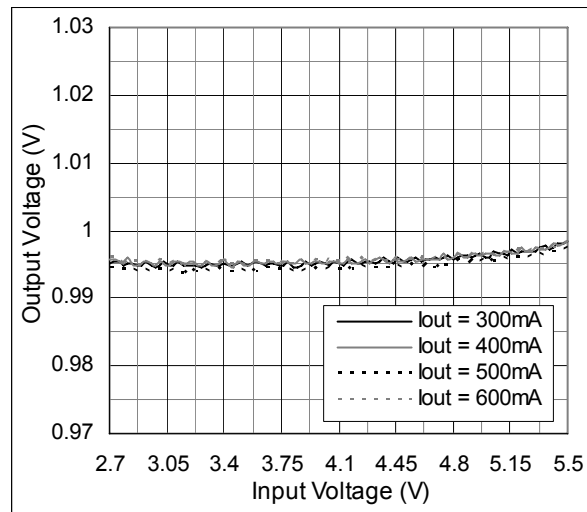


Figure 27. DC-DC Output Voltage Error vs. Reference Voltage

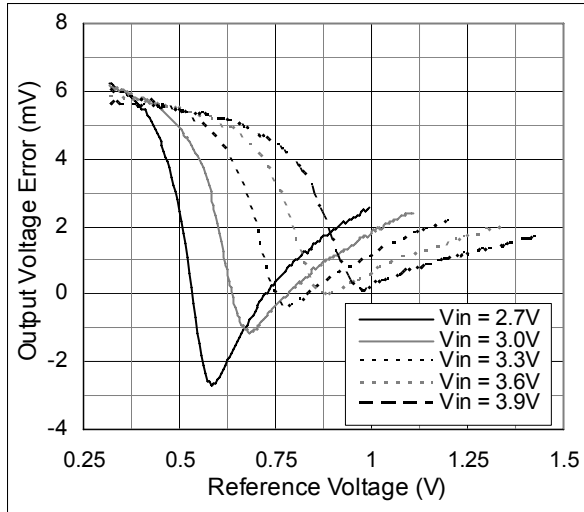


Figure 28. DC-DC Bypass Dropout Voltage vs. Output Current

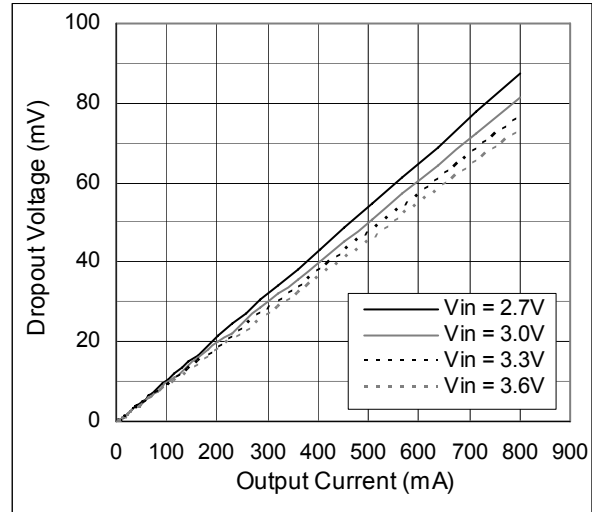


Figure 29. DC-DC No-Load Supply Current vs. VIN

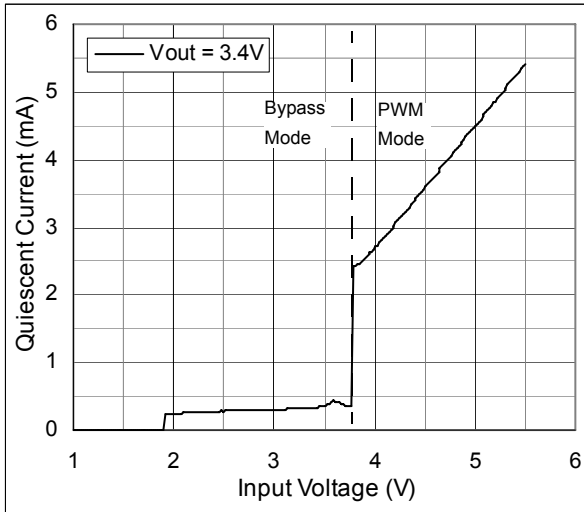


Figure 30. Shutdown Supply Current vs. VIN

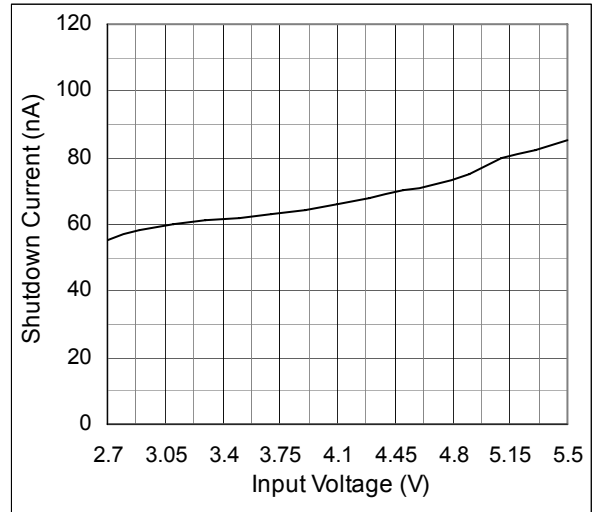


Figure 31. DC-DC Switching; VIN=3.6V, VPA=1.2V, IOUT=50mA

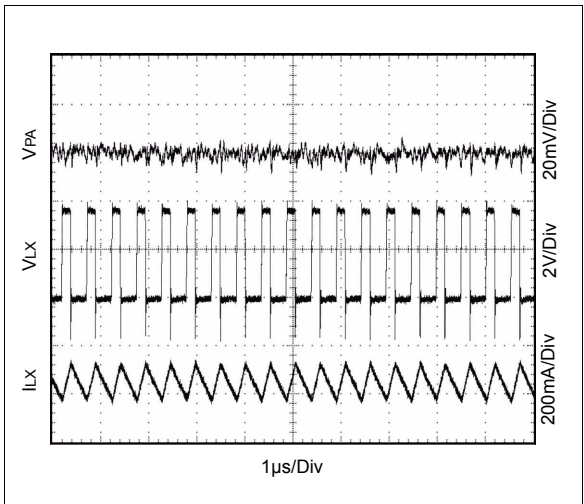


Figure 32. DC-DC Switching; VIN=3.6V, VPA=1.2V, IOUT=500mA

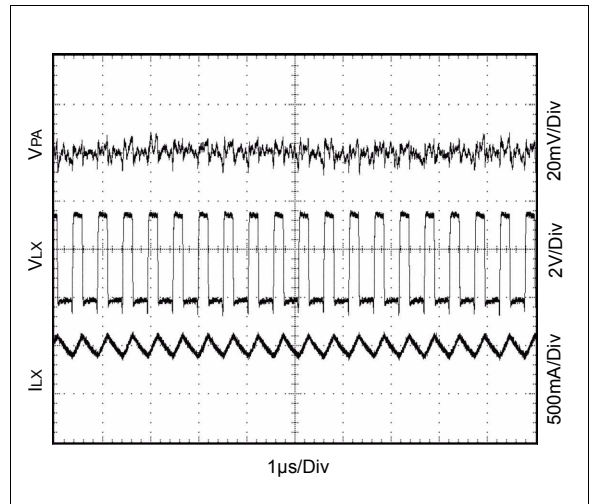


Figure 33. DC-DC Soft-Start; $R_{LOAD} = 7.5\Omega$

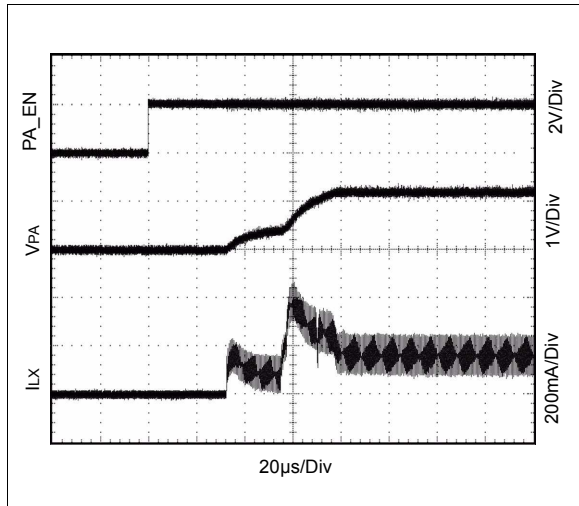


Figure 34. DC-DC Shutdown

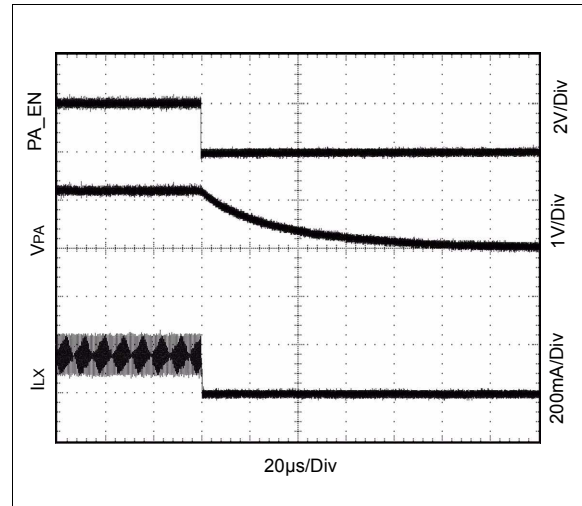


Figure 35. DC-DC Sine Wave Output in PWM Mode; $V_{IN} = 4.5V$, $R_{LOAD} = 7.5\Omega$

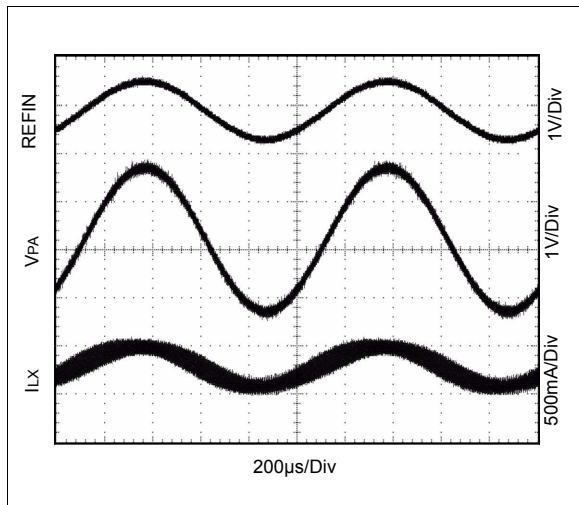


Figure 36. DC-DC Sine Wave Output in Bypass Mode; $V_{IN} = 3.6V$, $R_{LOAD} = 7.5\Omega$

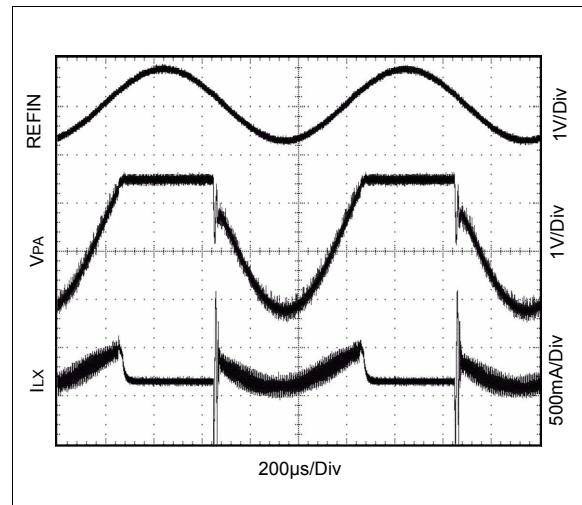


Figure 37. DC-DC Rectangular Wave Output in PWM Mode; $V_{IN} = 4.5V$, $R_{LOAD} = 7.5\Omega$

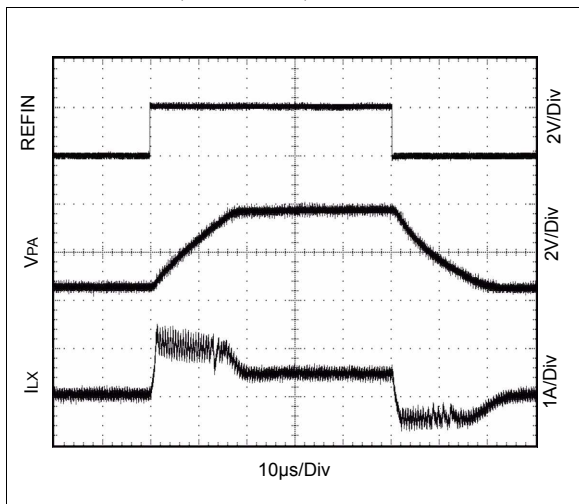


Figure 38. DC-DC Rectangular Wave Output in Bypass Mode; $V_{IN} = 3.6V$, $R_{LOAD} = 7.5\Omega$

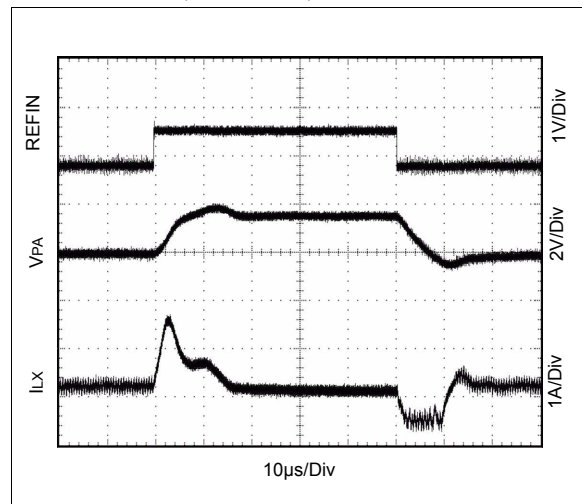


Figure 39. DC-DC Line Transient; $V_{IN} = 4.0V$ to $3.5V$, $V_{OUT} = 1.2V$, $R_{LOAD} = 10\Omega$

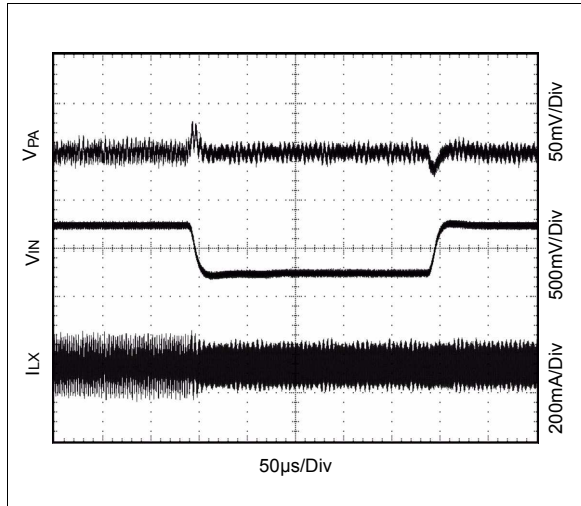


Figure 40. DC-DC Load Transient; $I_{OUT} = 0mA$ to $500mA$, $V_{IN} = 3.6V$, $V_{OUT} = 2.5V$

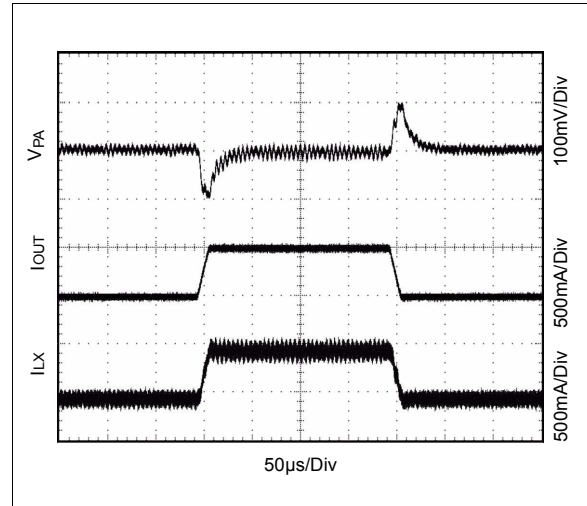


Figure 41. LDO Quiescent Current vs. V_{IN}

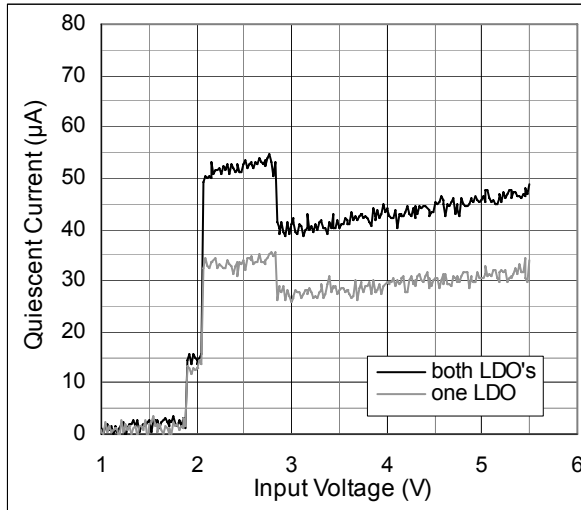


Figure 42. LDO Line Regulation, V_{OUT} vs. V_{IN}

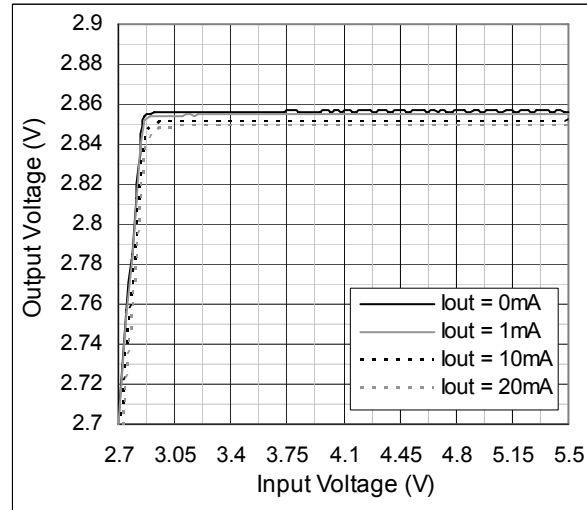


Figure 43. LDO PSRR vs. Freq.; $V_{IN} = 3.2V$, $V_{OUT} = 2.85V$, $V_{RIPPLE} = 200mV_{PP}$, $C_{OUT} = 100nF$

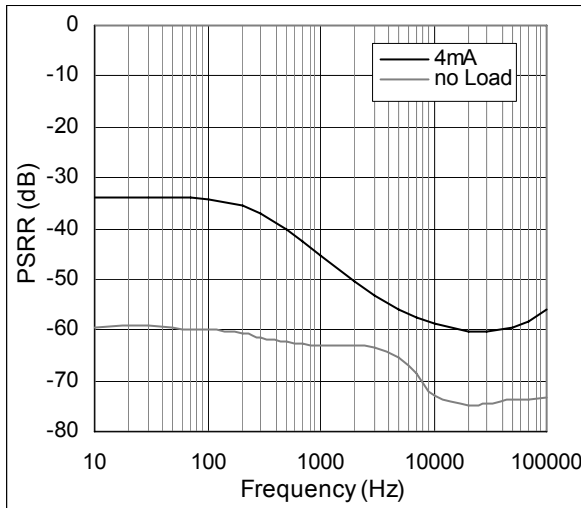


Figure 44. LDO Output Noise vs. Freq.; $V_{IN} = 3.2V$, $V_{OUT} = 2.85V$, $C_{OUT} = 100nF$

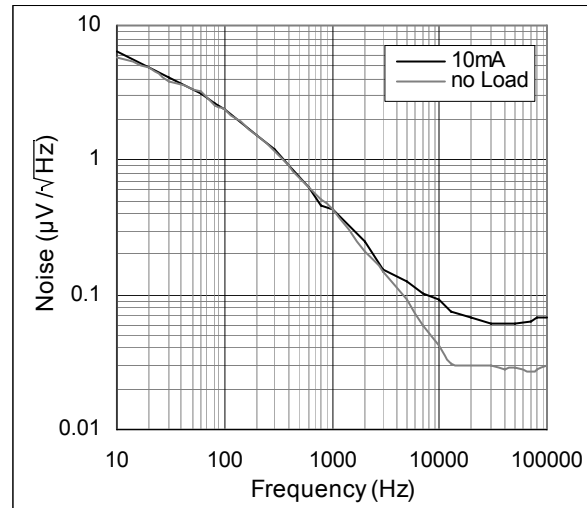


Figure 45. LDO Turn ON/OFF Response; $V_{IN} = 3.6V$, no load

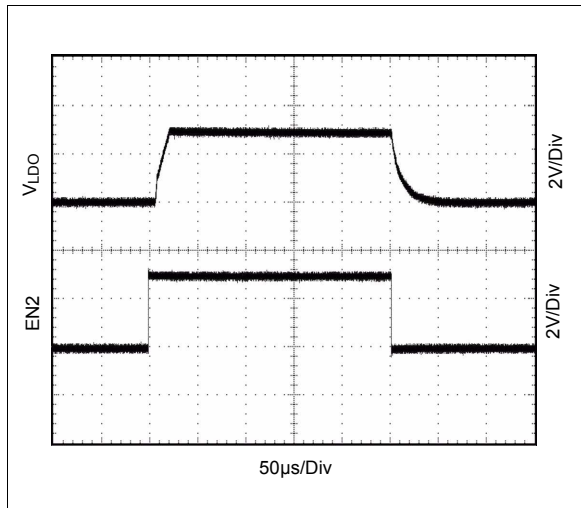


Figure 46. LDO Load Transient; $I_{OUT} = 0mA$ to $10mA$, $V_{IN} = 3.6V$

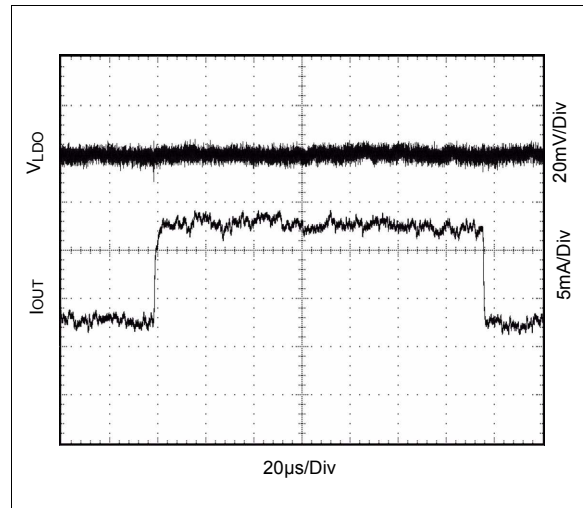


Figure 47. LDO Line Transient; $V_{IN} = 5.5V$ to $3.5V$, $I_{OUT} = 10mA$

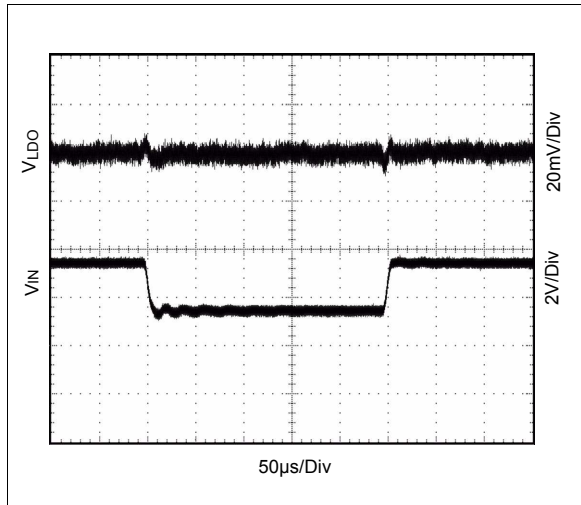
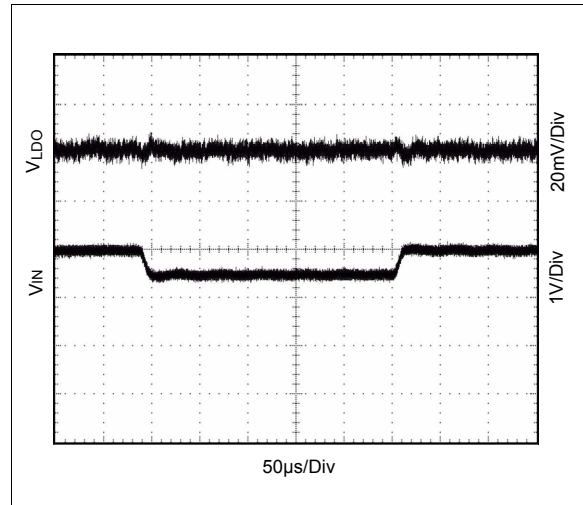


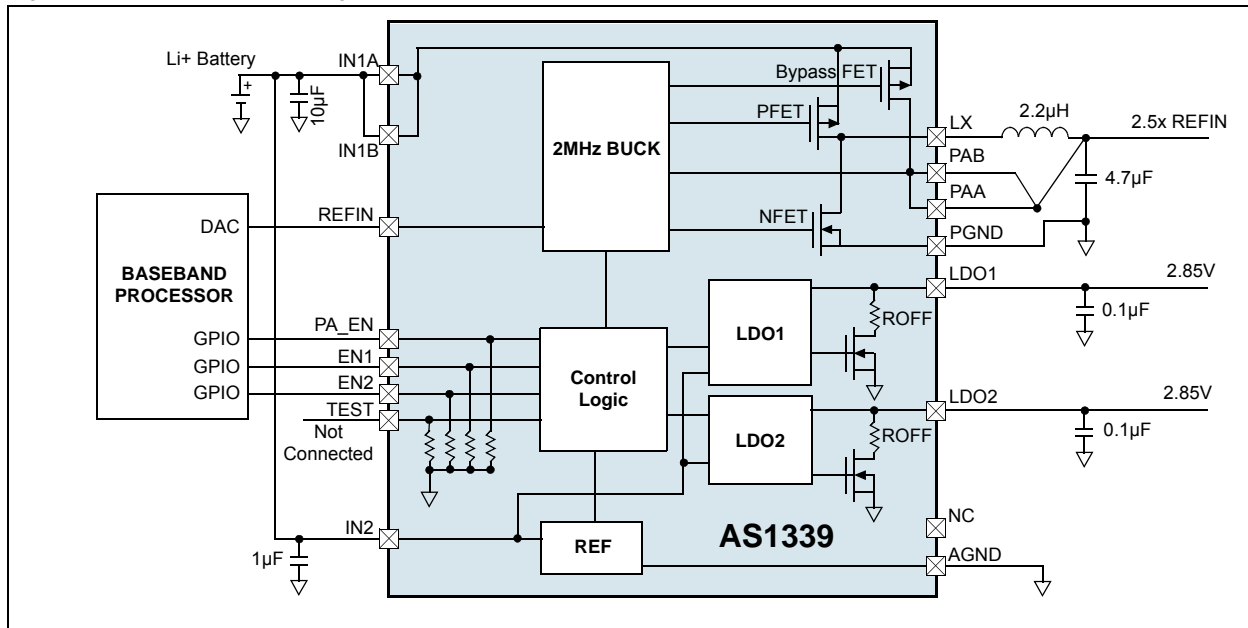
Figure 48. LDO Line Transient; $V_{IN} = 4.0V$ to $3.5V$, $I_{OUT} = 10mA$



8 Detailed Description

The AS1339 is designed to dynamically power the PA in WCDMA and NCDMA handsets. The device is empowered with a high-frequency, high-efficiency step-down converter, and two LDOs. The step-down converters are capable of delivering 650mA. The PWM control scheme provides fast transient response, while 2MHz switching frequency allows the trade-off between efficiency and small external components. A 110mΩ bypass FET connects the PA directly to the battery during high-power transmission.

Figure 49. AS1339 - Block Diagram



Operating the AS1339

The AS1339's control block turns on the internal PFET (P-channel MOSFET) switch during the first part of each switching cycle, thus allowing current to flow from the input through the inductor to the output filter capacitor and load. The inductor limits the current to a ramp with a slope of $(V_{IN} - V_{OUT}) / L$, by storing energy in a magnetic field.

During the second part of each cycle, the controller turns the PFET switch off, blocking current flow from the input, and then turns the NFET (N-channel MOSFET) synchronous rectifier on. As a result, the inductor's magnetic field collapses, generating a voltage that forces current from ground through the synchronous rectifier to the output filter capacitor and load.

While the stored energy is transferred back into the circuit and depleted, the inductor current ramps down with a slope of V_{OUT} / L . The output filter capacitor stores charge when the inductor current is high, and releases it when low, smoothing the voltage across the load. The output voltage is regulated by modulating the PFET switch on-time to control the average current sent to the load.

The output voltage is equal to the average voltage at the LX pin.

While in operation, the output voltage is regulated by switching at a constant frequency and then modulating the energy per cycle to control the power to the load. Energy per cycle is set by modulating the PFET switch on-time pulse width to control the peak inductor current. This is done by comparing the signal from the current-sense amplifier with a slope compensated error signal from the voltage-feedback error amplifier. At the beginning of each cycle, the clock turns on the PFET switch, causing the inductor current to ramp up. When the current sense signal ramps past the error amplifier signal, the PWM comparator turns off the PFET switch and turns on the NFET synchronous rectifier, ending the first part of the cycle.

If an increase in load pulls the output down, the error amplifier output increases, which allows the inductor current to ramp higher before the comparator turns off the PFET. This increases the average current sent to the output and

adjusts for the increase in the load. Before appearing at the PWM comparator, a slope compensation ramp from the oscillator is subtracted from the error signal for stability of the current feedback loop.

Internal Synchronous Rectifier

To reduce the rectifier forward voltage drop and the associated power loss, the AS1339 uses an internal NFET as a synchronous rectifier. The big advantage of a synchronous rectification is the higher efficiency in a condition where the output voltage is low compared to the voltage drop across an ordinary rectifier diode. During the inductor current down slope in the second part of each cycle the synchronous rectifier is turned on. Before the next cycle the synchronous rectifier is turned off.

There is no need for an external diode because the NFET is conducting through its intrinsic body diode during the transient intervals before it turns on.

Bypass Mode

This mode connects IN1A and IN1B directly to PAA and PAB with the internal 110m Ω (typ) bypass FET, while the step-down converter is forced into 100% duty-cycle operation during high-power transmission. Due to the low on-resistance in this mode, the result is low dropout, high efficiency and a high output current capability.

The AS1339 enters bypass mode automatically when $V_{IN} \leq 2.69 \times V_{REFIN}$ and thus prevents excessive output ripple as the step-down converter approaches dropout. Due to an internal limitation of $V_{REFIN} \leq 1.5V$ the maximum output voltage is limited to $2.78 \times 1.5V = 4.17V$ in Bypass Mode.

Shutdown Mode

To put the PA step-down converter in shutdown mode, connect PA_EN to GND or disconnect PA_EN (NC => logic-low). During shutdown mode, the control circuitry, internal switching MOSFET, and synchronous rectifier are turned off and LX becomes high impedance. For normal operation, connect PA_EN to IN1A/B or logic-high.

To place LDO1 or LDO2 in shutdown mode, connect EN1 or EN2 to GND or disconnect EN1 or EN2 (NC => logic-low). The outputs of the LDOs are pulled to ground through an internal 100 Ω resistor during shutdown. When the PA step-down and LDOs are all in shutdown, the AS1339 enters a very low power state, where the input current drops to 0.8 μA (typ).

Note: All enable Pins (PA_EN, EN1 and EN2) have an internal 110k Ω pull-down resistance.

Soft-Start

The internal soft-start circuitry of the PA step-down converter limits inrush current at startup, reducing transients on the input source. Soft-start is favorable for supplies with high output impedance such as Li+ and alkaline cells. The DC-DC can start-up with full output load of 7.5 Ω .

Analog REFIN Control

The PA step-down converter uses REFIN to set the output voltage, which enables the converter to operate in applications requiring dynamic voltage control. The output voltage is limited to an upper level of 3.85V, when operating in PWM mode. In Bypass mode the output voltage is limited to V_{IN} .

Notes:

1. $V_{OUT} = 2.5 \times V_{REFIN}$
2. If REFIN is left floating the output voltage of the step-down converter can assume any value between 0.6V and V_{IN} .

Thermal Overload Protection

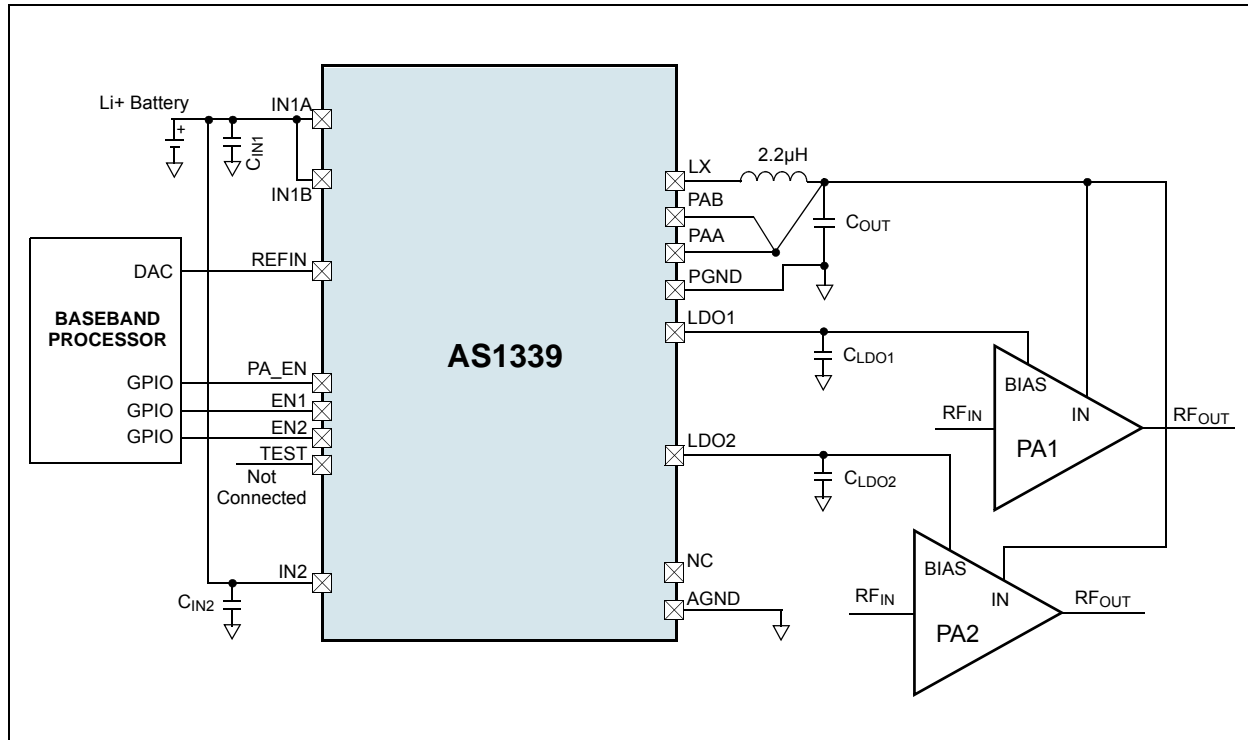
To prevent the AS1339 from short-term misuse and overload conditions the chip includes a thermal overload protection. To block the normal operation mode the device is turning off the PFET and the NFET in PWM and bypass mode as soon as the junction temperature exceeds 140 $^{\circ}C$. To resume the normal operation the temperature has to drop below 130 $^{\circ}C$.

Note: Continuing operation in thermal overload conditions may damage the device and is considered bad practice.

9 Application Information

The AS1339 is designed to supply power amplifiers for RF applications. The output power of the PA can directly be controlled via the output voltage of the AS1339. Figure 50 shows a typical application.

Figure 50. Typical Application Diagram



Capacitor Selection for Step-Down Converter

Input Capacitor

To reduce the current peaks drawn from the battery or power source and to reduce the switching noise in the device an input capacitor is highly recommended. At the switching frequency the impedance of the capacitor should be very low. It's recommended to use a X5R or X7R dielectric multilayer ceramic capacitor due to their small size, low ESR and small temperature coefficients. For most applications a 4.7µF capacitor is sufficient. To decrease the interfering noise and to lower the input ripple the capacitor value can be set higher (e.g. 10µF).

Output Capacitor

To ensure a stable loop regulation and a small output voltage ripple a low impedance capacitor should be used. It's recommended to use a X5R or X7R dielectric multilayer ceramic capacitor due to their small size, low ESR and small temperature coefficients. For most applications a 4.7µF capacitor is sufficient. To achieve a better load-transient performance and to decrease the output ripple the capacitor value can be set higher (e.g. 10µF).

Table 6. Recommended Capacitors for the Step-Down Converter

Name	Part Number	C	Voltage	Type	Size	Manufacturer
C _{IN1} , C _{OUT}	GRM21BR60J106KE01	10µF	6.3V	X5R	0805	Murata www.murata.com
	GRM21BR61C475KA88	4.7µF	16V	X5R	0805	
	C0603C475K8PAC7867	4.7µF	10V	X5R	0603	KEMET www.kemet.com

Capacitor Selection for LDO's

Input Capacitor

The capacitor for the LDO Input should have at least a value of the sum of the output capacitors of LDO1 and LDO2. With a larger input capacitance and lower ESR a better noise rejection and line transient response can be achieved.

Output Capacitor

For the LDO outputs the capacitor value depends on the needed load current. For a stable operation with rated maximum load currents a minimum output capacitor of 1 μ F is recommended. At light loads of 10mA or less a 0.1 μ F capacitor is sufficient. With larger output capacitance a reduced output noise, improved load-transient response, better stability and power-supply rejection can be achieved.

Table 7. Recommended Capacitors for the LDO's

Name	Part Number	C	Voltage	Type	Size	Manufacturer
C _{IN2} , CLDO1, CLDO2	C0402C104K4RAC	100nF	16V	X7R	0402	KEMET www.kemet.com
	GRM155R61A105KE15	1 μ F	10V	X5R	0402	Murata www.murata.com

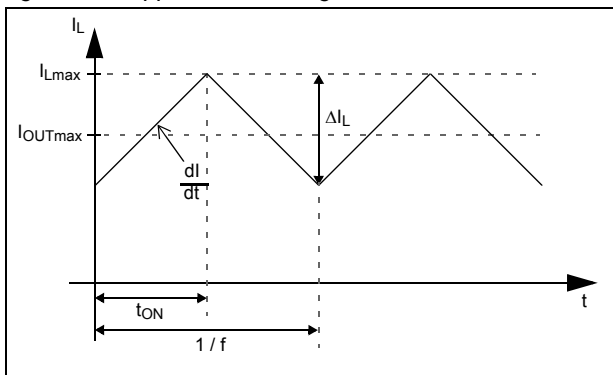
Inductor Selection

For most applications the value of the external inductor should be in the range of 1.5 μ H to 4.7 μ H as the inductor value has a direct effect on the ripple current. The selected inductor must be rated for its DC resistance and saturation current. The inductor ripple current (ΔI_L) decreases with higher inductance and increases with higher V_{IN} to V_{OUT} .

In Equation (EQ 3) the maximum inductor current in PWM mode under static load conditions is calculated. The saturation current of the inductor should be rated higher than the maximum inductor current as calculated with Equation (EQ 4). This is recommended because the inductor current will rise above the calculated value during heavy load transients.

The inductor current ripple ΔI_L (see EQ 3) is defined by the slope of the current (dI/dt) (see EQ 1) multiplied by the PFET on-time t_{ON} (see EQ 2).

Figure 51. Ripple Current Diagram



$$\frac{dI}{dt} = \frac{V_{IN} - V_{OUT}}{L} \quad (\text{EQ 1})$$

$$t_{ON} = \text{DutyCycle} \times \frac{1}{f} \quad \text{DutyCycle} = \frac{V_{OUT}}{V_{IN}} \quad (\text{EQ 2})$$

$$\Delta I_L = \frac{V_{OUT} \times (V_{IN} - V_{OUT})}{V_{IN} \times f \times L} \quad (\text{EQ 3})$$

$$I_{LMAX} = I_{OUTMAX} + \frac{\Delta I_L}{2} \quad (\text{EQ 4})$$

f Switching Frequency (2.0MHz typical)

L Inductor Value

I_{LMAX} Maximum Inductor current

ΔI_L Peak to Peak inductor ripple current

I_{OUTMAX} Applied load current

Accepting larger values of ripple current allows the use of low inductance values, but results in higher output voltage ripple, greater core losses, and lower output current capability. The total losses of the coil have a strong impact on the efficiency of the dc/dc conversion and consist of both the losses in the dc resistance and the following frequency-dependent components:

1. The losses in the core material (magnetic hysteresis loss, especially at high switching frequencies)
2. Additional losses in the conductor from the skin effect (current displacement at high frequencies)
3. Magnetic field losses of the neighboring windings (proximity effect)
4. Radiation losses

Note: For highest efficiency, a low DC-resistance inductor is recommended.

Table 8. Recommended Inductors

Part Number	L	DCR	Current Rating	Dimensions (L/W/T)	Manufacturer
MLP2520S1R5S	1.5μH	80mΩ	1.5A	2.5x2.0x1.2mm	TDK www.tdk.com
MLP2520S2R2S	2.2μH	110mΩ	1.2A	2.5x2.0x1.2mm	
MLP2520S3R3S	3.3μH	110mΩ	1.0A	2.5x2.0x1.2mm	
EPL2014-222MLC	2.2μH	120mΩ	0.98A	2.2x2.0x1.4mm	Coilcraft www.coilcraft.com
EPL2014-332MLC	3.3μH	152mΩ	0.8A	2.2x2.0x1.4mm	
EPL2014-472MLC	4.7μH	231mΩ	0.65A	2.2x2.0x1.4mm	
XPL2010-222ML	2.2μH	156mΩ	1.2A	2.0x1.9x1.0mm	
XPL2010-332ML	3.3μH	207mΩ	0.925A	2.0x1.9x1.0mm	

Figure 52. Efficiency Comparison of different Inductors; $V_{IN} = 3.9V$, $V_{OUT} = 1.0V$

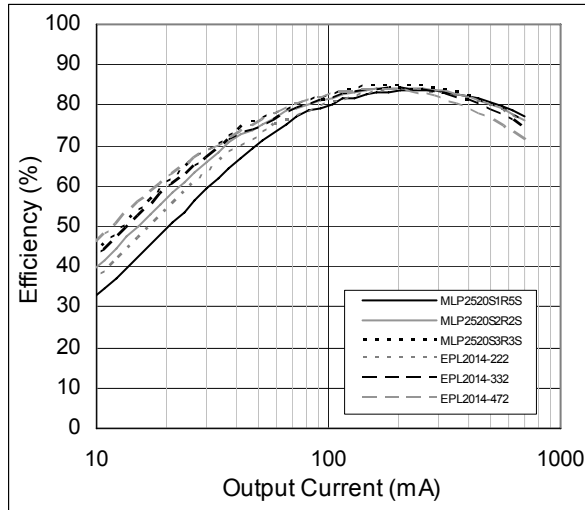
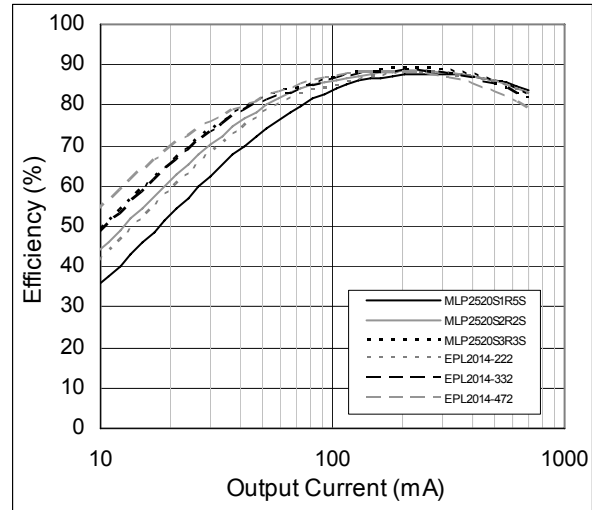


Figure 53. Efficiency Comparison of different Inductors; $V_{IN} = 3.9V$, $V_{OUT} = 1.5V$



Example

The following system should be designed:

- A supply with a Lithium-Ion Battery = 4.5V
- $V_{OUT} = 3.0V$
- $I_{OUTMAX} = 500mA$

For the first step V_{REF} is calculated as shown in Equation (EQ 5).

$$V_{REF} = \frac{V_{OUT}}{2,5} = 1,2V \quad (EQ 5)$$

$$V_{IN} \leq 2,69 \times V_{REF} \quad (EQ 6)$$

Due to Equation (EQ 6): $V_{IN} = 3.23V$

If V_{IN} is falling below 3.23V the device is going into Bypass mode (see Bypass Mode on page 17).

Hence a 2.2 μ H coil is used, ΔI_L can be calculated with Equation (EQ 3): $\Delta I_L = 227mA$

With this result I_{MAX} can be calculated with Equation (EQ 4): $I_{MAX} = 614mA$.

The saturation current of the coil should be chosen slightly higher than I_{MAX} because heavy load transients could increase the peak current. For a short period of time (~50 μ s) the peak inductor current can rise up to a value of approximately 1.1A (p-channel MOSFET peak current limit). In this case a coil with a rated saturation current of ~800mA can be chosen.

Layout Considerations

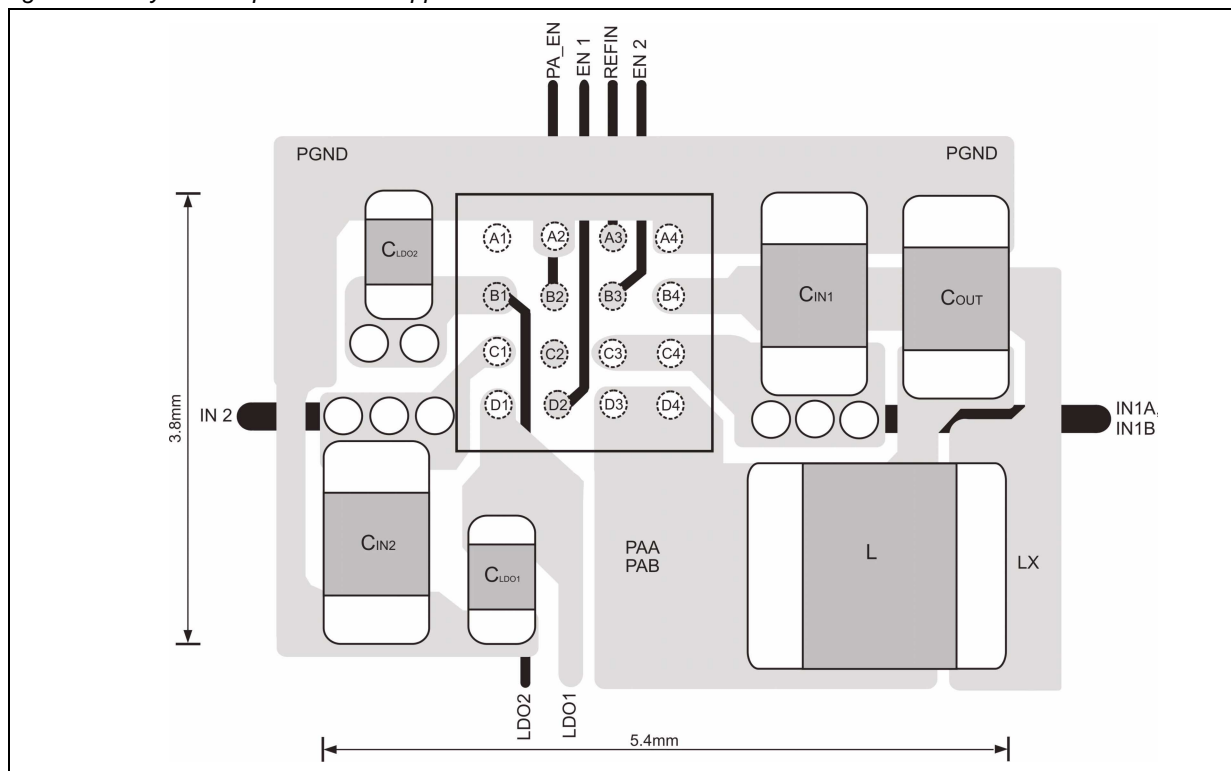
Please carefully observe that large peak currents of up to 1.1A and high switching frequencies will make the PCB layout a very important part of the system performance and compliance. A proper PCB design will minimize electro magnetic interference (EMI) as well as voltage gradients in the ground plane, which both can result in application instabilities. Please closely follow the guidelines as mentioned below.

- Keep the power traces as short and wide as possible (IN1A, IN1B, IN2, LX, PAA, PAB, PGND)
- Place all capacitors as close as possible to the pins of the device
- Avoid voltage gradients in the ground plane

Please note the following PCB layout considerations shown in [Figure 54](#):

- The negative terminals of COUT and CIN1/CIN2 are kept as close as possible to each other. It is recommended to connect these terminals directly to PGND at a star point.
- The current path between pins IN1A/IN1B (C3/C4) and pin PGND (A4) via CIN1 is routed very short
- The current path between pins PAB/PAA (D3/D4) and pin PGND (A4) via COUT is routed very short
- The connection between LX (B4) and pins PAB/PAA (D3/D4) via the coil (L) is routed very short
- To keep the cross-coupling between the LDOs and DC/DC minimized, in regard to supply ripple and noise induction, the IN1 and IN2 path are separated. Both power inputs should be connected at a star point directly at the main supply
- To prevent voltage gradients between AGND (A2) and PGND (A4), these pins are connected via a short, low ohmic, trace to each other.

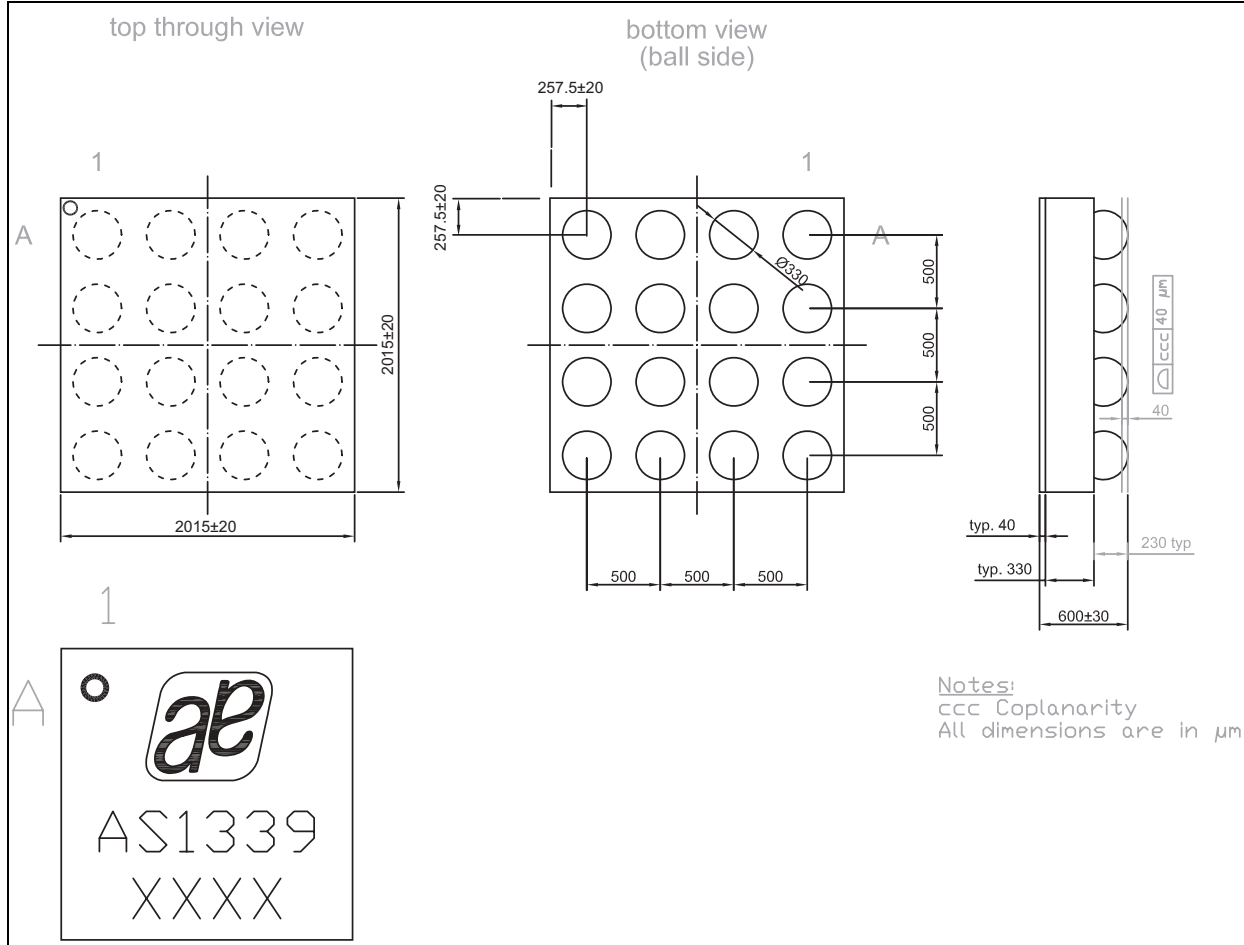
Figure 54. Layout for Space Limited Applications



10 Package Drawings and Markings

The devices are available in a 16-pin WLP (2x2mm) package.

Figure 55. 16-pin WLP (2x2mm) Package



11 Ordering Information

The devices are available as the standard products shown in [Table 9](#).

Table 9. Ordering Information

Ordering Code	Marking	Description	Delivery Form	Package
AS1339-BWLT	AS1339	650mA RF Step-Down DC-DC for PA, with two LDOs	Tape and Reel	16-pin WLP (2x2mm)

Note: All products are RoHS compliant and Pb-free.

Buy our products or get free samples online at ICdirect: <http://www.austriamicrosystems.com/ICdirect>

For further information and requests, please contact us <mailto:sales@austriamicrosystems.com>
or find your local distributor at <http://www.austriamicrosystems.com/distributor>

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